Notice of References Cited Application/Control No. 10/579,349 Examiner ANDREW OH Applicant(s)/Patent Under Reexamination YUN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,341,229 A	08-1994	Rowan, Larry	359/10
*	В	US-5,402,418 A	03-1995	Shibata et al.	370/264
*	C	US-5,907,366 A	05-1999	Farmer et al.	348/478
*	D	US-5,963,302 A	10-1999	Wittek, Gotz-Ulrich	352/38
*	Е	US-5,974,444 A	10-1999	Konrad, Allan M.	709/203
*	F	US-6,007,338 A	12-1999	DiNunzio et al.	434/55
*	G	US-6,275,213 B1	08-2001	Tremblay et al.	345/156
*	Ι	US-2001/0036868 A1	11-2001	Roy et al.	472/130
*	-	US-2002/0054608 A1	05-2002	Wan et al.	370/474
*	J	US-2002/0150123 A1	10-2002	Ro, Sookwang	370/465
*	K	US-2003/0162595 A1	08-2003	Serbanescu, Razz	472/1
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.